

TEST REPORT

Product Name : CM3399 Core Board Model Number : CM3399-V3

Prepared for Address	:	BOARDCON TECHNOLOGY LIMITED ROOM702, XINAN BUSINESS BUILDING, 45ZONE, BAOAN DISTRCT
Prepared by Address	::	EMTEK (SHENZHEN) CO., LTD. Building 69, Majialong Industry Zone, Nanshan District, Shenzhen, Guangdong, China Tel: (0755) 26954280 Fax: (0755) 26954282
Report Number	:	ENS2112140001E00201R

Report Number	•	
Date of Test	:	December 14, 2021 to December 20, 2021
Date of Report	:	December 20, 2021





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TEST REPORT DESCRIPTION

Applicant : BOARDCON TECHNOLOGY LIMITED

Manufacturer : BOARDCON TECHNOLOGY LIMITED

Trade Mark : N/A

EUT : CM3399 Core Board

Model Number [:] CM3399-V3

Power supply : AC 230V/50Hz, AC 120V/60Hz

Measurement Procedure Used:

EN 55032:2015+A11:2020, EN IEC 61000-3-2:2019, EN 61000-3-3:2013+A1:2019, EN 55035:2017+A11:2020 (IEC 61000-4-2:2008, IEC 61000-4-3:2006+A1:2007+A2:2010, IEC 61000-4-4:2012, IEC 61000-4-5:2014, IEC 61000-4-6:2013, IEC 61000-4-8:2009, IEC 61000-4-11:2004)

The device described above is tested by EMTEK (SHENZHEN) CO., LTD. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and EMTEK (SHENZHEN) CO., LTD. is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 55032, EN 61000-3-2, EN 61000-3-3, EN 55035 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of EMTEK (SHENZHEN) CO., LTD.

Date of Test	:	December 14, 2021 to December 20, 2021
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Prepared by	:	SHENZHEN
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Modified Information

Version	Report No.	Revision Date	Summary	
Ver.1.0	ENS2112140001E00201R	/	Original Report	





1. DESCRIPTION OF STANDARDS AND RESULTS (EUT)

		EMISSIO	N			
Descrip	tion of	Test Item	Standard		Limits	Results
Conducted Emissions From	m the	AC Mains Power Ports			Class B	Pass
W	Vired r	network ports				N/A
	Optical	fibre ports			Class B	N/A
conducted emissions B	Broadc	ast receiver tuner ports			Class B	N/A
A	ntenn	a ports			Class B	N/A
	V broa	adcast receiver tuner ports			Class B	N/A
Conducted differential R voltage emissions	RF mod	dulator output ports	EN 55032	2	Class B	N/A
F	M bro	adcast receiver tuner ports			Class B	N/A
Radiated emissions at free	quenci	es up to 1 GHz			Class B	Pass
Radiated emissions at free	quenci	es above 1 GHz			Class B	Pass
Radiated emissions from F	- FM rec	eivers			Table A.6	N/A
Outdoor units of home sate	ellite r	eceiving systems			Table A.7	N/A
Harmonic Current Emissio			EN 61000-3-2:	2019	Class A	Pass
Voltage Fluctuation and Fl	licker		EN61000-3-3:20 2019	13+A1:	Section 5	Pass
		IMMUNIT	Y			
Descrip	tion of	f Test Item	Basic Stand	ard	Performan ce Criteria	Results
Electrostatic Discharge		Enclosure ports	IEC 61000-4-2	:2008	В	Pass
Continuous RF electromag	gnetic	Enclosure ports	IEC 61000-4-3: A1:2007+A2:2		A	Pass
		AC mains power ports			В	Pass
Electrical fast transients/bu	urst	Analogue/digital data ports	IEC61000-4-4:2012		В	N/A
		DC network power ports			N/A	N/A
		AC mains power ports				Pass
Surges		Analogue/digital data ports	IEC 61000-4-5:2014		С	N/A
2		DC network power ports	1		N/A	N/A
		AC mains power ports			A	Pass
Continuous induced RF		Analogue/digital data ports	IEC 61000-4-6	:2013	A	N/A
disturbances		DC network power ports		-	N/A	N/A
Power frequency magnetic	c field	Enclosure ports	IEC 61000-4-8	:2009	A	Pass
	ions	AC mains power ports	IEC 61000-4-11		B, C	Pass

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Report No. ENS2112140001E00201R



2. GENERAL INFORMATION

2.1. Description of Device (EUT)

EUT	: CM3399 Core Board
Model Number	: CM3399-V3
Applicant	: BOARDCON TECHNOLOGY LIMITED
Address	: ROOM702, XINAN BUSINESS BUILDING, 45ZONE, BAOAN DISTRCT
Manufacturer	: BOARDCON TECHNOLOGY LIMITED
Address	: ROOM702, XINAN BUSINESS BUILDING, 45ZONE, BAOAN DISTRCT
Date of Received	: December 14, 2021
Date of Test	: December 14, 2021 to December 20, 2021

- 2.2. Independent Operation Modes
 - A. On



2.3. Test Manner

Test Items	Test Voltage	Operation Modes	Worst case
Conducted disturbance at mains Terminals	AC 230V/50Hz AC 120V/60Hz	Mode A Mode A	Mode A (AC 120V/60Hz)
Radiated emissions at frequencies up to 1 GHz	AC 230V/50Hz AC 120V/60Hz	Mode A Mode A	Mode A (AC 120V/60Hz)
Radiated emissions at frequencies above 1 GHz	AC 230V/50Hz AC 120V/60Hz	Mode A Mode A	Mode A (AC 120V/60Hz)
Harmonic Current Emissions	AC 230V/50Hz	Mode A	١
Voltage Fluctuation and Flicker	AC 230V/50Hz	Mode A	/
Electrostatic Discharge	AC 230V/50Hz	Mode A	\
Continuous RF electromagnetic field disturbances	AC 230V/50Hz	Mode A	\
Electrical fast transients/burst	AC 230V/50Hz	Mode A	١
Surges	AC 230V/50Hz	Mode A	\
Continuous induced RF disturbances	AC 230V/50Hz	Mode A	\
Power frequency magnetic field	AC 230V/50Hz	Mode A	\
Voltage dips and interruptions	AC 230V/50Hz AC 120V/60Hz	Mode A	\

2.4. Description of Support Device

N/A



2.5. Description of Test Facility

Site Description	า	
EMC Lab.	:	Accredited by CNAS, 2018.11.30
		The certificate is valid until 2022.10.28
		The Laboratory has been assessed and proved to be in compliance with
		CNAS-CL01:2006 (identical to ISO/IEC 17025:2017) The Certificate Registration Number is L2291.
		The Octimente Registration Number is L2251.
		Accredited by FCC, August 09, 2018
		Designation Number: CN1204
		Test Firm Registration Number: 882943
		Appredited by A2LA August 09, 2019
		Accredited by A2LA, August 08, 2018 The Certificate Number is 4321.01.
		Agaradited by Industry Canada, Nevershar 00, 2010
		Accredited by Industry Canada, November 09, 2018 The Conformity Assessment Body Identifier is CN0008
		The Conformity Assessment Dody Identifier is Chooco
Name of Firm	:	EMTEK (SHENZHEN) CO., LTD.
Site Location	:	Building 69, Majialong, Industry Zone, Nanshan District, Shenzhen,
		Guangdong, China 516025

2.6. Measurement Uncertainty

Test Item Conducted Emission Uncertainty	:	Uncertainty 2.08dB (9k~150kHz Conduction 1#) 2.40dB (150k-30MHz Conduction 1#)
Radiated Emission Uncertainty (3m 3# Chamber)	:	4.40dB (30M~1GHz Polarize: H) 5.04dB (30M~1GHz Polarize: V) 4.94dB (1~6GHz)
Uncertainty for Flicker test	:	0.07%
Uncertainty for Harmonic test	:	1.8%
Uncertainty for C/S Test	:	1.45(Using CDN Test) 2.37(Using EM Clamp Test)
Uncertainty for R/S Test	:	2.10dB(80MHz-200MHz) 1.76dB(200MHz-1000MHz)
Uncertainty for test site temperature and humidity	:	0.6℃ 4%



3. MEASURING DEVICE AND TEST EQUIPMENT

3.1. For Conducted Emissions At the AC Mains Power Ports

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	EMI Test Receiver	Rohde & Schwarz	ESCI	101384	May 15, 2021	1 Year
\checkmark	AMN	Rohde & Schwarz	ENV216	101161	May 15, 2021	1 Year
\checkmark	AMN	Kyoritsu	KNW-407	8-1492-9	May 16, 2021	1 Year

3.2. For Radiated Emission Measurement (3m)

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	EMI Test Receiver	Rohde & Schwarz	ESU 26	100154	May 15, 2021	1 Year
	Pre-Amplifie	Lunar EM	LNA10M1G-40	J10111309 12001	May 15, 2021	1 Year
\checkmark	Bilog Antenna	Schwarzbeck	VULB9163	VULB9163 659		2 Year
V	Horn antenna	Horn antenna Schwarzbeck BBHA		9120D-117 7	July 04, 2020	2 Year
V	Pre-Amplifie	SKET	LNPA_0118G-45	SK201905 1801	May 15, 2021	1 Year



Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
N	45KVA AC Power source	Teseq	NSG Teseq 1007-45/45KV 1305A02873 May 16, A		May 16, 2021	1 Year
	Signal conditioning Unit	Teseq	CCN 1000-3	1305A02873	May 16, 2021	1 Year
\checkmark	Impedance network	Teseq	INA2197/37A	1305A02873	May 16, 2021	1 Year
N	Impedance network	Teseq	INA 2196/75A	1305A02874	May 16, 2021	1 Year
	Profline 2100 AC Switching Unit	Teseq	NSG 2200-3	A22714	May 16, 2021	1 Year

3.3. For Harmonic Current / Flicker Measurement

3.4. For Electrostatic Discharge Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	ESD Tester	TESEQ AG	NSG 438A	130	May 15, 2021	1 Year

3.5. For Continuous RF Electromagnetic Field Disturbances Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	Power Amplifier	MILMEGA	AS0102-55	1018770	May 15, 2021	1 Year
V	50ohm Diode Power Sensor	BOONTON	51011EMC	34236	May 16, 2021	1 Year
V	RF Power Meter. Dual Channel	BOONTON	4232A	10539	May 15, 2021	1 Year
\checkmark	LogPer. Antenna	SCHWARZBECK	VULP 9118E	811	N/A	N/A
\checkmark	Signal Generator	Agilent	N5181A	MY50145187	May 15, 2021	1 Year
V	50ohm Diode Power Sensor	BOONTON	51011EMC	36164	May 15, 2021	1 Year
V	Broad-Band Horn Antenna	SCHWARZBECK	STLP 9149	9149-227	N/A	N/A
V	Field Strength Meter	DARE	RSS1006A	10I00037SNO 22	May 16, 2021	1 Year
V	Multi-function interface system	DARE	CTR1009B	12I00250SNO 72	N/A	N/A
V	Automatic switch group	DARE	RSW1004A	N/A	N/A	N/A
\checkmark	Power Amplifier	MILMEGA	AS1860-50	1059346	May 15, 2021	1 Year
V	Power Amplifier	MILMEGA	80RF1000-17 5	1059345	May 15, 2021	1 Year

3.6. For Electrical Fast Transient / Burst Immunity

Usec	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	Burst Tester	HAEFELY	PEFT4010	080981-16	May 16, 2021	1 Year
\checkmark	Coupling Clamp	HAEFELY	IP-4A	147147	May 16, 2021	1 Year



3.7. For Surges Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	Controller HAEFELY		Psurge 8000	174031	May 16, 2021	1 Year
\checkmark	Impulse Module HAEFELY		PIM 100	174124	May 16, 2021	1 Year
\checkmark	Coupling Decoupling	HAEFELY	PCD 130	172181	May 16, 2021	1 Year
\checkmark	Coupling Module	HAEFELY	PCD122	174354	May 16, 2021	1 Year
\checkmark	Impulse Module	HAEFELY	PIM 120	174435	May 16, 2021	1 Year
\checkmark	Coupling Module	HAEFELY	PCD 126A	174387	May 16, 2021	1 Year
\checkmark	Impulse Module	HAEFELY	PIM 110	174391	May 16, 2021	1 Year
\checkmark	Impulse Module	HAEFELY	PIM 150	178707	May 16, 2021	1 Year

3.8. For Continuous Induced RF Disturbances Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
	Continuous Wave Simulator	EMTEST	CWS500C	0900-12	May 15, 2021	1 Year
V	CDN	EMTEST	CDN-M2	51001001001 0	May 16, 2021	1 Year
	CDN	EMTEST	CDN-M3	0900-11	May 15, 2021	1 Year
	EM Injection Clamp	EMTEST	F-2031-23MM	368	May 15, 2021	1 Year
\checkmark	Attenuator	EMTEST	100W 6dB DC-3G	/	May 15, 2021	1 Year
\checkmark	Power meter	AGILENT	E4418B	MY45102886	May 15, 2021	1 Year
\checkmark	Signal Generator R&S SMB100A 103		103041	May 15, 2021	1 Year	

3.9. For Power Frequency Magnetic Field Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
\checkmark	Magnetic Field Tester	HAEFELY	MAG100	250040.1	May 15, 2021	1 Year

3.10. For Voltage Dips And Interruptions Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
V	45KVA AC Power source	Teseq	NSG 1007-45/45KV A	1305A02873	May 16, 2021	1 Year
	Signal conditioning Unit	Teseq	CCN 1000-3	1305A02873	May 16, 2021	1 Year
	Impedance network	Teseq	INA2197/37A	1305A02873	May 16, 2021	1 Year
	Impedance network	Teseq	INA 2196/75A	1305A02874	May 16, 2021	1 Year
V	Profline 2100 AC Switching Unit	Teseq	NSG 2200-3	A22714	May 16, 2021	1 Year

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4. CONDUCTED EMISSIONS FROM THE AC MAINS POWER PORTS

Metal ground plane Metal ground plane Test receiver AMN AMN

4.1. Block Diagram of Test Setup

AMN: Artificial Mains Network AE: Associated equipment EUT: Equipment under test

4.2. Limits

EN 55032, Class B, Table A.10

Frequency range MHz	Coupling device (see Table A.8)	Detector type / bandwidth	Class B limits dB(µV)
0.15 to 0.5			66 to 56
0.5 to 5	AMN	Quasi Peak / 9 kHz	56
5 to 30			60
0.15 to 0.5			56 to 46
0.5 to 5	AMN	Average / 9 kHz	46
5 to 30			50

4.3. Test Procedure

The EUT was placed on a plank 0.8 m height from the metal ground plane and 0.4 m from the conducting wall of the shielding room and it was kept at least 0.8 m from any other grounded conducting surface. The size of the table will nominally be 1.5 m x1.0 m.

The rear of the arrangement shall be flush with the back of the supporting tabletop unless that would not be possible or typical of normal use.

All units of equipment forming the system under test (includes the EUT as well as connected peripherals and associated equipment or devices) shall be arranged such that a nominal 0.1 m separation is achieved between the neighboring units.

Connect EUT to the power mains through a artificial mains network (AMN). Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle

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no longer than 0.4 m, so that its length is shortened to 1 m.

All the support units are connecting to the other AMN.

The AMN provides 50 ohm coupling impedance for the measuring instrument.

The CISPR states that the AMN with 50 ohm and 50 microhenry should be used.

Both sides of AC line were checked for maximum conducted interference.

The frequency range from 150 kHz to 30 MHz was sweep.

Set the test-receiver system to quasi peak detect function and average detect function, and to measure the conducted emissions values.

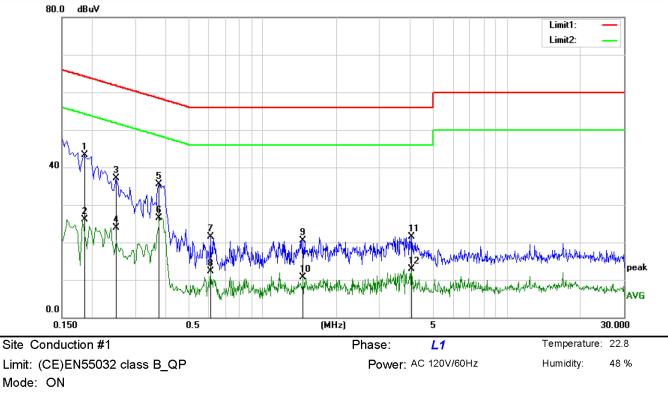
Test results were obtained from the following equation: Emission Level (dB μ V) = AMN Factor (dB) + Cable Loss (dB) + Reading (dB μ V) Margin (dB) = Emission Level (dB μ V) - Limit (dB μ V)

4.4. Measuring Results

PASS.

Please see the attached page.

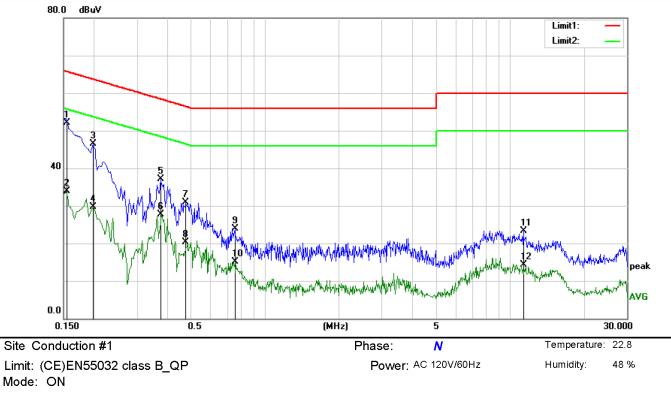




Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	*	0.1860	33.78	9.46	43.24	64.21	-20.97	QP	
2		0.1860	16.57	9.46	26.03	54.21	-28.18	AVG	
3		0.2500	27.84	9.36	37.20	61.76	-24.56	QP	
4		0.2500	14.62	9.36	23.98	51.76	-27.78	AVG	
5		0.3740	26.09	9.32	35.41	58.41	-23.00	QP	
6		0.3740	17.11	9.32	26.43	48.41	-21.98	AVG	
7		0.6100	12.30	9.27	21.57	56.00	-34.43	QP	
8		0.6100	2.95	9.27	12.22	46.00	-33.78	AVG	
9		1.4580	10.62	9.92	20.54	56.00	-35.46	QP	
10		1.4580	0.74	9.92	10.66	46.00	-35.34	AVG	
11		4.0620	11.53	9.92	21.45	56.00	-34.55	QP	
12		4.0620	2.95	9.92	12.87	46.00	-33.13	AVG	





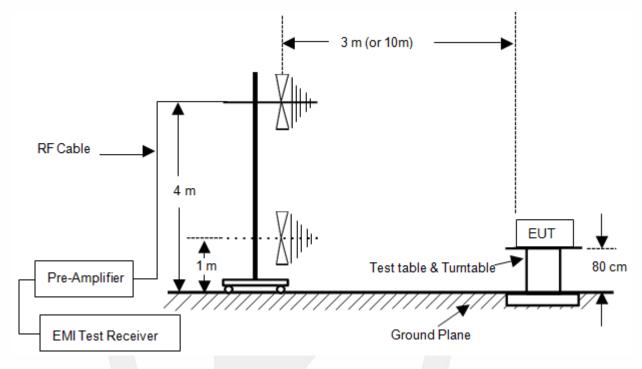
Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	*	0.1548	42.61	9.56	52.17	65.74	-13.57	QP	
2		0.1548	24.25	9.56	33.81	55.74	-21.93	AVG	
3		0.1980	37.02	9.43	46.45	63.69	-17.24	QP	
4		0.1980	20.35	9.43	29.78	53.69	-23.91	AVG	
5		0.3740	27.69	9.32	37.01	58.41	-21.40	QP	
6		0.3740	18.38	9.32	27.70	48.41	-20.71	AVG	
7		0.4740	21.64	9.27	30.91	56.44	-25.53	QP	
8		0.4740	11.12	9.27	20.39	46.44	-26.05	AVG	
9		0.7540	14.56	9.39	23.95	56.00	-32.05	QP	
10		0.7540	5.64	9.39	15.03	46.00	-30.97	AVG	
11		11.3300	13.23	10.15	23.38	60.00	-36.62	QP	
12		11.3300	4.18	10.15	14.33	50.00	-35.67	AVG	



5. RADIATED EMISSION MEASUREMENT (UP TO 1GHz)

5.1. Block Diagram of Test Setup



5.2. Radiated Limit

EN 55032, Class B, Table A.4

Frequency range		Class A limits			
MHz	Facility	Distance (m)	Detector type / bandwidth	dB(µV/m)	
30 to 230	OATS/SAC	10		30	
230 to 1 000	UAT 5/5AC	10	Quasi Peak / 120 kHz	37	
30 to 230	OATS/SAC	2		40	
230 to 1 000	UAT 5/5AC	3		47	

5.3. Test Procedure

The EUT was placed on a non-conductive table whose total height equaled 80cm. All units of equipment forming the system under test (includes the EUT as well as connected peripherals and associated equipment or devices) shall be arranged such that a nominal 0.1 m separation is achieved between the neighboring units. Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, so that its length is shortened to 1 m.

The EUT was set 3 meters (or 10 meters) away from the receiving antenna that was mounted on a non-conductive mast. The antenna can move up and down between 1 to 4 meters to find out the

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maximum emission level.

The turntable can rotate 360 degree to determine the position of the maximum emission level.

The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest emission with respect to the limit was found by investigating emissions at a number of significant frequencies. The probable frequency of maximum emission had been found and that the associated cable and EUT configuration and mode of operation had been identified.

The bandwidth of the Receiver is set at 120 kHz.

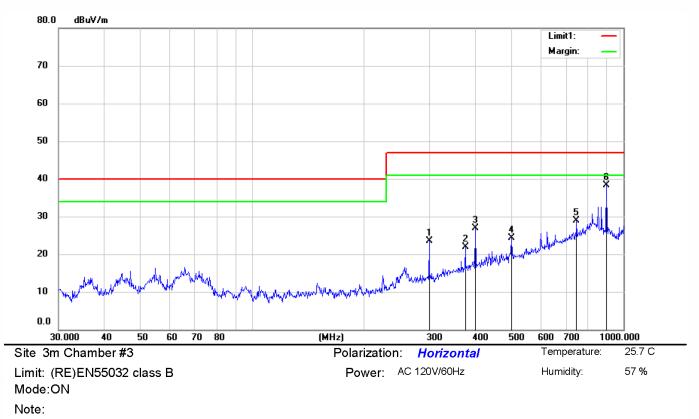
Test results were obtained from the following equation: Emission level $(dB\mu V/m)$ = Antenna Factor - Amp Factor + Cable Loss + Reading Margin (dB) = Emission Level $(dB\mu V/m)$ - Limit $(dB\mu V/m)$

5.4. Measuring Results

PASS.

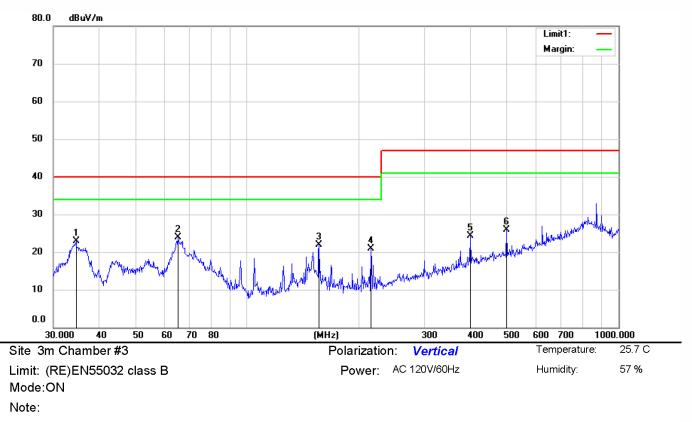
Please see the attached page.





No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		300.1040	36.30	-12.81	23.49	47.00	-23.51	QP			
2		375.1155	32.16	-10.31	21.85	47.00	-25.15	QP			
3		400.0810	36.32	-9.41	26.91	47.00	-20.09	QP			
4		500.0818	31.44	-7.20	24.24	47.00	-22.76	QP			
5		750.1082	30.55	-1.56	28.99	47.00	-18.01	QP			
6	*	900.1474	38.92	-0.55	38.37	47.00	-8.63	QP			



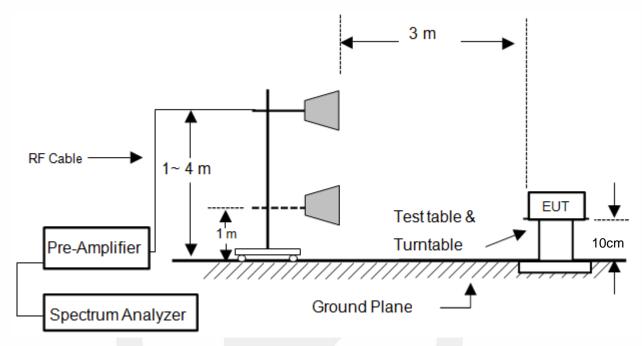


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		34.6233	39.45	-16.64	22.81	40.00	-17.19	QP			
2	*	64.9720	38.71	-14.85	23.86	40.00	-16.14	QP			
3		155.9785	39.15	-17.30	21.85	40.00	-18.15	QP			
4		216.0240	37.58	-16.73	20.85	40.00	-19.15	QP			
5		400.0810	33.79	-9.41	24.38	47.00	-22.62	QP			
6		500.0818	33.14	-7.20	25.94	47.00	-21.06	QP			



6. RADIATED EMISSION MEASUREMENT (ABOVE 1GHz)

6.1. Block Diagram of Test Setup



6.2. Radiated Limit

EN 55032, Class B, Table A.50

Frequency range		Measurement					
(MHz)	Facility	Distance (m)	Detector type/ bandwidth	dB(µV/m)			
1000 to 3000		3		50			
3000 to 6000			Average / 1 MHz	54			
1000 to 3000	FSOATS			70			
3000 to 6000			Peak /1 MHz	74			

Note: The highest internal source of an EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes. If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

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6.3. Test Procedure

The EUT was placed on a non-conductive table whose total height equaled 80cm. All units of equipment forming the system under test (includes the EUT as well as connected peripherals and associated equipment or devices) shall be arranged such that a nominal 0.1 m separation is achieved between the neighboring units. Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, so that its length is shortened to 1 m.

The EUT was set 3 meters away from the receiving antenna that was mounted on a non-conductive mast. The antenna can move up and down between 1 to 4 meters to find out the maximum emission level.

The turntable can rotate 360 degree to determine the position of the maximum emission level.

The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest emission with respect to the limit was found by investigating emissions at a number of significant frequencies. The probable frequency of maximum emission had been found and that the associated cable and EUT configuration and mode of operation had been identified.

The frequency range above 1GHz the measuring instrument use RBW=1 MHz and VBW=3 MHz.

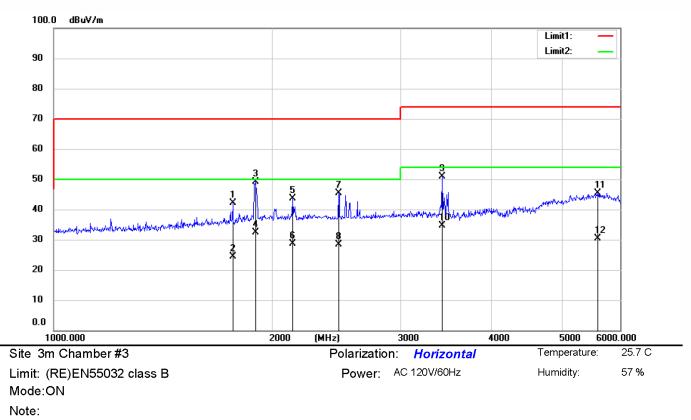
Test results were obtained from the following equation: Emission level $(dB\mu V/m) =$ Antenna Factor - Amp Factor + Cable Loss + Reading Margin (dB) = Emission Level $(dB\mu V/m)$ - Limit $(dB\mu V/m)$

6.4. Measuring Results

PASS

All the modes were tested and the data of the worst modes are attached the following pages.



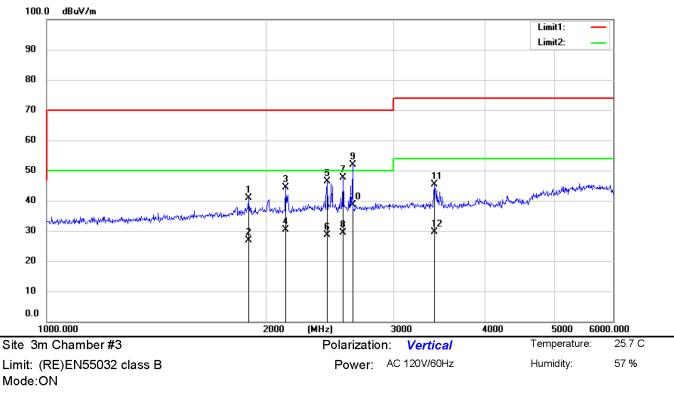


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		1763.922	56.55	-14.43	42.12	70.00	-27.88	peak			
2		1763.922	38.93	-14.43	24.50	50.00	-25.50	AVG			
3		1897.532	62.85	-13.62	49.23	70.00	-20.77	peak			
4	*	1897.532	46.12	-13.62	32.50	50.00	-17.50	AVG			
5		2133.821	56.63	-12.95	43.68	70.00	-26.32	peak			
6		2133.821	41.55	-12.95	28.60	50.00	-21.40	AVG			
7		2465.451	58.20	-12.94	45.26	70.00	-24.74	peak			
8		2465.451	41.24	-12.94	28.30	50.00	-21.70	AVG			
9		3421.376	63.06	-12.16	50.90	74.00	-23.10	peak			
10		3421.376	46.76	-12.16	34.60	54.00	-19.40	AVG			
11		5602.566	50.31	-4.91	45.40	74.00	-28.60	peak			
12		5602.566	35.41	-4.91	30.50	54.00	-23.50	AVG			

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Report No. ENS2112140001E00201R





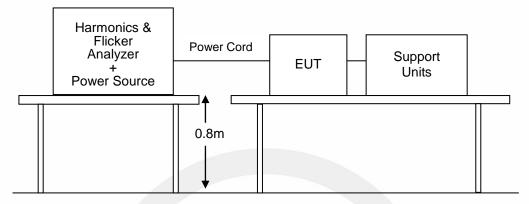
Note:

No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		1893.711	54.58	-13.65	40.93	70.00	-29.07	peak			
2		1893.711	40.45	-13.65	26.80	50.00	-23.20	AVG			
3		2131.433	57.31	-12.96	44.35	70.00	-25.65	peak			
4		2131.433	43.36	-12.96	30.40	50.00	-19.60	AVG			
5		2427.643	59.38	-12.93	46.45	70.00	-23.55	peak			
6		2427.643	41.63	-12.93	28.70	50.00	-21.30	AVG			
7		2555.403	60.38	-12.87	47.51	70.00	-22.49	peak			
8		2555.403	42.37	-12.87	29.50	50.00	-20.50	AVG			
9		2632.079	64.59	-12.77	51.82	70.00	-18.18	peak			
10	*	2632.079	51.37	-12.77	38.60	50.00	-11.40	AVG			
11		3415.251	57.59	-12.16	45.43	74.00	-28.57	peak			
12		3415.251	41.76	-12.16	29.60	54.00	-24.40	AVG			



7. HARMONIC CURRENT EMISSION MEASUREMENT

7.1. Block Diagram of Test Setup



7.2. Standard Limits

EN 61000-3-2, CLASS A

Harmonic current emissions evaluate the potential for the EUT to cause distortion on the AC power lines. It is applicable to electrical and electronic equipment having an input current≤16 A per phase, and intended to be connected to public low-voltage distribution systems

Harmonic order n	Maximum permissible harmonic current (A)				
Odd ha	rmonics				
3	2.30				
5	1.14				
7	0.77				
9	0.40				
11	0.33				
13	0.21				
15 ≤ n ≤ 39	0.15 <u>0.15</u>				
Even ha	rmonics				
2	1.08				
4	0.43				
6	0.30				
8 ≤ n ≤ 40	0.23 <u>8</u>				

Table 1 - Limits for Class A equipment



7.3. Test Procedure

The measurement of harmonic currents shall be performed as follows: i. For each harmonic order, measure the 1.5 s smoothed r.m.s. harmonic current in each DFT time window as defined in EN / IEC 61000-4-7:2009. ii. Calculate the arithmetic average of the measured values from the DFT time windows, over the entire observation period Short cyclic (T cycle≤2.5 min). Because of synchronisation to meet the requirements for repeatability in 5%.

7.4. Test Results

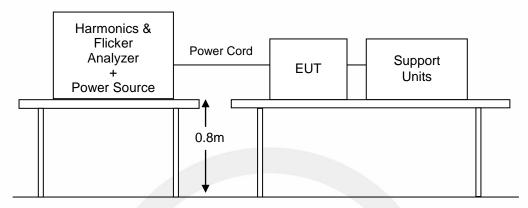
N/A.

Because power of EUT less than 75W, According standard EN 61000-3-2, Harmonic current unnecessary to test.



8. VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

8.1. Block Diagram of Test Setup



8.2. Standard Limits

EN 61000-3-3 Limits

The objective of voltage changes, voltage fluctuations and flicker in public low voltage supply systems during equipment with rated current≤16 A per phase, ensures that home appliances and certain other electrical equipment do not adversely affect lighting equipment when connected to the same power system.

Voltage Fluctuation and Flicker Limits:

- the value of Pst shall not be greater than 1.0;
- the value of Plt shall not be greater than 0.65;
- the value of d(t) during a voltage change shall not exceed 3.3 % for more than 500 ms;
- the relative steady-state voltage change, dc, shall not exceed 3.3 %;
- the maximum relative voltage change, dmax, shall not exceed 4.0 %;

8.3. Test Procedure

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of 8% is achieved during the whole assessment procedure.

8.4. Test Results

PASS

All the modes were tested and the data of the worst modes are attached the following pages.

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European Limits

Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

EUT: CM3399-V3Tested by: LHTTest category: All parameters (European limits)Test Margin: 100Test date: 2021/12/15Start time: 23:11:12End time: 23:21:39Test duration (min): 10Data file name: WIN2105_F-000026.cts_dataComment: ONCustomer: BOARDCON TECHNOLOGY LIMITED

Test Result: Pass

Status: Test Completed

Pst_i and limit line



Parameter values recorded dur	ing the tes	st:		
Vrms at the end of test (Volt):	220.72			
T-max (mS):	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.04	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.288	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.126	Test limit:	0.650	Pass



9. IMMUNITY GENERAL PERFORMANCE CRITERIA DESCRIPTION

General performance criteria are defined in EN 55035 clause 8.2, 8.3 and 8.4. These criteria shall be used during the testing of primary functions where no relevant annex is applicable.

When assessing the impact of a disturbance on a function, the assessment should take into consideration the function's performance prior to the application of the disturbance and only identify as failures those changes in performance that are a result of the disturbance.

EN 55035:

Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

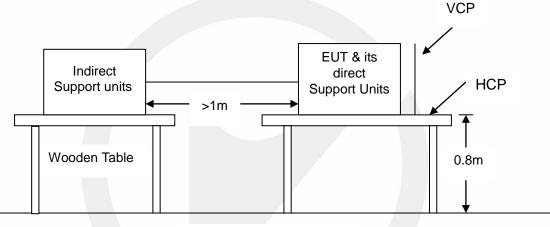


10. ELECTROSTATIC DISCHARGE

10.1.Test Specification

Test standard	:	EN 55035
Basic standard	:	IEC 61000-4-2
Performance criterion	:	В
Test level	:	±8.0kV (Air discharge) ±4.0kV (Contact discharge)

10.2.Block Diagram of Test Setup



Ground Reference Plane

10.3.Test Procedure

a. In the case of air discharge testing, the climatic conditions shall be within the following ranges:

- ambient temperature: 15°C to 35°C;

- relative humidity : 30% to 60%;

- atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar)

b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.

c. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

d. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted : - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate. - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge. - The contact discharge test shall not be applied to such surfaces.

e. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

f. The test voltage shall be increased from the minimum to the selected test severity level, in order to

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determine any threshold of failure. The final test level should not exceed the product specification value in order to avoid damage to the equipment.

g. The test shall be performed with both air discharge and contact discharge. The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied. For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred. h. Ensure that the applied charge on the EUT has been dis-charged before next ESD pulse.

10.4.Test Results

PASS

Temperature	:	23.3°C
Humidity	:	45%
Atmospheric Pressure	:	101kpa
Test Engineer	Ξ.	LHT
Test Date	4	2021-12-15

Air Discharge:

Test Voltage	Location	Actual criterion	Required performance criterion	Result (Pass/Fail)
±2; 4; 8 kV	SLOT	A	В	Pass

Contact Discharge

Test Voltage	Location	Actual criterion	Required performance criterion	Result (Pass/Fail)
±2; 4kV	USB/SCREW/HD MI/LAN	A	В	Pass

Indirect Discharge

Test Voltage	Location	Actual criterion Required criterion criterion		Result (Pass/Fail)	
±2; 4 kV	HCP	А	В	Pass	
±2; 4kV	VCP	А	В	Pass	

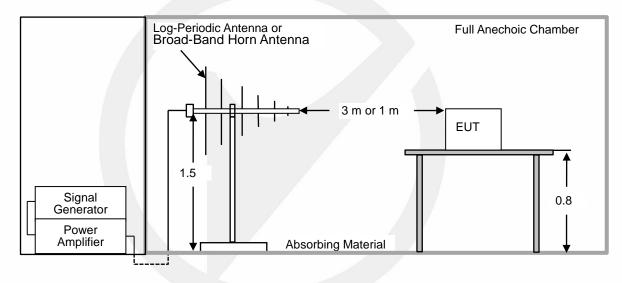


11. CONTINUOUS RF ELECTROMAGNETIC FIELD DISTURBANCES

11.1.Test Specification

Test standard	:	EN 55035	
Basic standard	:	IEC 61000-4-3	
Performance criterion	:	A	
Frequency range &	:	⊠80M-1000MHz	3V/m
Test level		Spot frequency	3V/m
		Additional spot frequency	3V/m
Modulation	:	AM, 80%, 1kHz sine-wave	

11.2.Block Diagram of Test Setup



11.3.Test procedure

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

a. The antenna which is enabling the complete frequency range of 80-1000 MHz is placed 3m (or 1m) away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the antenna.
b. The test is performed with the antenna facing the front and back sides of the EUT with. Both vertical and horizontal polarizations from antenna are tested.



11.4.Test results

PASS

Temperature	:	23.7°C
Humidity	:	52%
Atmospheric Pressure	:	101kpa
Test Engineer	:	LHT
Test Date	:	2021-12-15

80M-1000MHz:

Freq. Range (MHz)	Field	Modulation	Polarity	Position (°)	Actual criterion	Required performance criterion	Result
80-1000	3V/m	AM, 80%	H/V	0, 90,180, 270	А	А	Pass

Spot frequency:

Freq (MHz)	Field	Modulation	Polarity	Position (°)	Actual criterion	Required performance criterion	Result
1800, 2600, 3500, 5000	3V/m	AM, 80%	H/V	0, 90,180, 270	А	А	Pass

Additional spot frequency:

Freq (MHz)	Field	Modulation	Polarity	Position (°)	Actual criterion	Required performance criterion	Result
80, 120, 160, 230, 434, 460, 600, 863, 900	3V/m	AM, 80%	H/V	0, 90,180, 270	N/A	А	N/A

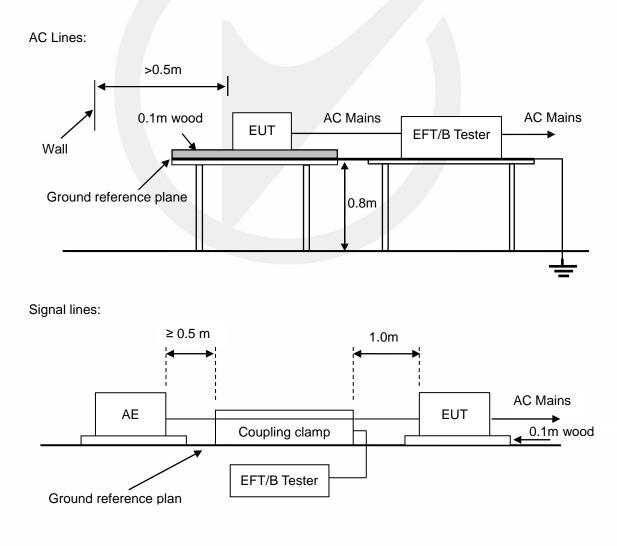


12. ELECTRICAL FAST TRANSIENTS/BURST

12.1.Test Specification

Test standard		EN 55035
Basic standard	•	IEC 61000-4-4
Performance criterion	:	В
Test level	:	⊠1kV, AC mains power ports
		0.5kV, DC network power ports
		0.5kV, Analogue/digital data ports
Repetition frequency	:	\boxtimes 5kHz, \square 100kHz(Only xDSL ports)
Tr/Th:	:	5/50ns
Burst period	:	300ms
Test time :	:	120s

12.2.Block Diagram of Test Setup





12.3.Test Procedure

The EUT is put on the table that is 0.1 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

12.4.Test Results

PASS

Temperature	:	25.4°C
Humidity	:	50%
Atmospheric Pressure	:	101kpa
Test Engineer	:	LHT
Test Date	: 2	2021-12-15

Injection Line	Voltage (kV)	Injected Method	Actual criterion	Required performance criterion	Result (Pass/Fail)
AC mains power ports	± 1	CDN Direct injection Capacitive coupling clamp	А	В	Pass
DC network power ports	± 0.5	CDN Direct injection Capacitive coupling clamp	N/A	N/A	N/A
Analogue/digital data ports (Wired network port)	± 0.5	CDN Direct injection Capacitive coupling clamp	A	В	N/A
Analogue/digital data ports (Broadcast receiver tuner port)	± 0.5	CDN Direct injection Capacitive coupling clamp	N/A	N/A	N/A
Analogue/digital data ports ()	± 0.5	CDN Direct injection Capacitive coupling clamp	N/A	N/A	N/A

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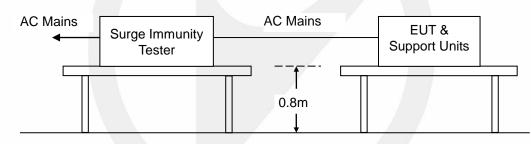


13. SURGES

13.1.Test Specification

Test standard Basic standard Test level	EN 55035 IEC 61000-4-5 ⊠1kV, Line to Line, AC mains power ports, Criterion B ⊠2kV, Line to Earth, AC mains power ports, Criterion B □0.5kV, Line to Reference ground, DC network power ports, Criterion B □1.0kV, Lines to Ground, Unshielded symmetrical, Criterion C □4.0kV, Lines to Ground, Unshielded symmetrical, Criterion C □0.5kV, Shield to ground, Coaxial or shielded port, Criterion B
Number of surges	5 (for each combination of parameters)
Repetition rate	1 minute / time
Polarity:	Positive / Negative
Phase angle:	90°, 270° (Only AC mains power ports)

13.2.Block Diagram of Test Setup



13.3.Test Procedure

This test simulates a lightning event by inducing transients onto the AC/DC power supply lines in common mode (Line to Ground) and differential mode (Line to Line). Each device was tested in a total of two surge configurations: Line to Ground (L-G): Combination Wave, Line to Protective Earth with 9uF and 10Ohm and Neutral to Protective Earth with 9uF and 10Ohm, common mode, generator earthed. Line to Line (L-L): Combination Wave,

Line to Neutral with 18uF, differential mode, generator floated.

2 ohm : the source impedance of the low-voltage power supply network.

12 ohm : the source impedance of the low-voltage power supply network and ground.

a. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave (positive and negative).

b. The surges have to be applied line to line and line to earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.

c. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan. All lower levels including the selected test level shall be satisfied.

d. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level (let-through level) of the primary protection.

e. Testing shall be performed according to a Test Plan, which shall be included in the test report.

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f. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied.

13.4.Test results

PASS

Temperature	:	25.4°C
Humidity	:	50%
Atmospheric Pressure	:	101kpa
Test Engineer	:	LHT
Test Date	:	2021-12-15

\boxtimes AC mains power ports:

Coupling Line	Voltage (kV)	Waveform (µs)	Polarity	Actual criterion	Required performance criterion	Result (Pass/Fail)
Line to line	0.5, 1	1.2/50 (8/20)	Pos./ Neg.	А	В	Pass
Line to earth	0.5, 1, 2	1.2/50 (8/20)	Pos./ Neg.	A	В	Pass

DC network power ports:

Coupling Line	Voltage (kV)	Waveform (µs)	Polarity	Actual criterion	Required performance criterion	Result (Pass/Fail)
Line to Reference ground	0.5	1.2/50 (8/20)	Pos./ Neg.	N/A	В	N/A

Analogue/digital data ports:

Port type	Coupling Line	Voltage (kV)	Waveform (µs)	Polarity	Actual criterion	Required performance criterion	Result (Pass/Fail)
Unshielded symmetrical (Wired network port)	Lines to ground	0.5, 1	10/700 (5/320)	Pos./ Neg.	A	С	N/A
Unshielded Symmetrical ()	Lines to ground	0.5, 1	10/700 (5/320)	Pos./ Neg.	N/A	С	N/A
Unshielded symmetrical	Lines to ground	0.5, 1, 2, 4	10/700 (5/320)	Pos./ Neg.	N/A	С	N/A
Coaxial or shielded (Broadcast receiver tuner port)	Shield to ground	0.5	1.2/50 (8/20)	Pos./ Neg.	N/A	С	N/A
Coaxial or shielded ()	Shield to ground	0.5	1.2/50 (8/20)	Pos./ Neg.	N/A	С	N/A

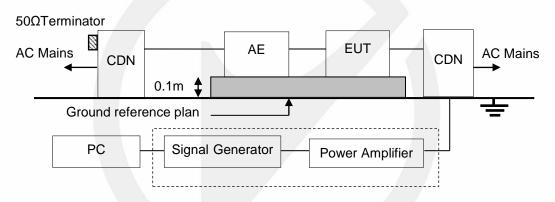


14. CONTINUOUS INDUCED RF DISTURBANCES

14.1.Test Specification

Test standard	:	EN 55035
Basic standard	:	IEC 61000-4-6
Performance criterion	:	A
Frequency range &	:	0.15M to 10MHz, 3V
Test level		10M to 30MHz, 3V to 1V
		30M to 80MHz, 1V
Modulation	:	AM 80%, 1kHz sine-wave
Frequency Step	:	1% of fundamental

14.2.Block Diagram of Test Setup



14.3.Test Procedure

a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.

b. The EUT is placed on a 0.1m high test table, and a well grounded cable is connected to metallic plane above the test table.

c. All cables/wires must be laid out on test plate (3cm in thickness),and the EUT is set up on test plate (10 cm in thickness) as shown in test setup photo, and the cables/wires must not be in mid-air, they should be touching the surface of test plate. Ensure that the EUT is properly connected to the accessory equipment. d. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.

e. The frequency range is swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1 kHz sine wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5 x 10-3 decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.

f. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency (ies) and harmonics or frequencies of dominant interest shall be analyzed separately.

g. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility

h. Testing shall be performed according to a Test Plan, which shall be included in the test report.

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14.4.Test results

PASS

Temperature	:	25.4°C
Humidity	:	50%
Atmospheric Pressure	:	101kpa
Test Engineer	:	LHT
Test Date	:	2021-12-15

Range (MHz)	Levers (V)	Injection port	Coupling type	Actual criterion	Required performance criterion	Result (Pass/Fail)	
0.15-10	3						
10-30	3-1	AC mains power ports	EM Clamp	А	А	Pass	
30-80	1		Direct injection				
0.15-10	3						
10-30	3-1	DC network power	EM Clamp	N/A	N/A	N/A	
30-80	1		Direct injection				
0.15-10	3	Analogue/digital data					
10-30	3-1	ports	EM Clamp Current Clamp	А	А	N/A	
30-80	1	(Wired network port)	Direct injection				
0.15-10	3	Analogue/digital data					
10-30	3-1	ports (Broadcast receiver tuner	EM Clamp	N/A	N/A	N/A	
30-80	1	port)	Direct injection				
0.15-10	3	Analogue/digital data					
10-30	3-1	ports	EM Clamp	N/A	N/A	N/A	
30-80	1	()	Direct injection				

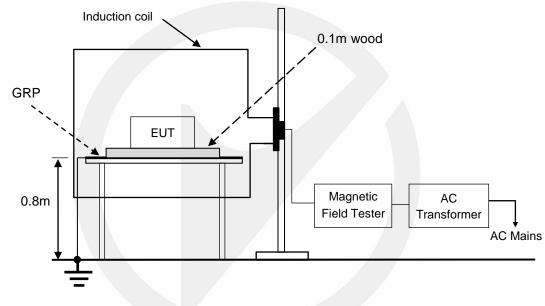


15. POWER FREQUENCY MAGNETIC FIELD

15.1.Test Specification

Test Standard	:	EN 55035
Basic Standard	:	IEC 61000-4-8
Performance criterion	:	А
Test level	:	1A/m

15.2.Block Diagram of Test Setup



GRP: Ground reference plane EUT: Equipment under test

15.3.Test Procedure

The EUT is placed in the middle of a induction coil (1*1m), under which is a 1*1*0.1m (high) table, this small table is also placed on a larger table, 0.8 m above the ground. Both horizontal and vertical polarization of the induction coil is set on test, so that each side of the EUT is affected by the magnetic field. Also can reach the same aim by change the position of the EUT.



15.4.Test Results

PASS

Temperature	:	25.4°C
Humidity	:	50%
Atmospheric Pressure	:	101kpa
Test Engineer	:	LHT
Test Date	:	2021-12-15

Test Level (A/m)	Frequency	Testing Duration	Coil Orientation	Actual criterion	Required performance criterion	Result (Pass/Fail)
1	⊠ 50Hz ⊠ 60Hz	5 mins	⊠ x-axis ⊠ y-axis ⊠ z-axis	A	A	Pass

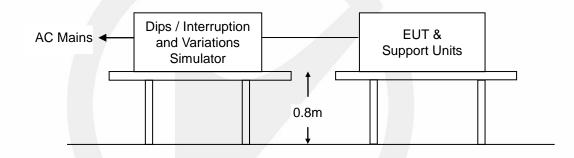


16. VOLTAGE DIPS AND INTERRUPTIONS

16.1.Test Specification

Test standard	: EN 55035
Basic standard	: IEC 61000-4-11
Test level	: 0%, 0.5 period, Criterion B
	⊠70%, 25 periods for 50Hz, Criterion C
	⊠70%, 30 periods for 60Hz, Criterion C
	⊠0%, 250 periods for 50Hz, Criterion C
	\boxtimes 0%, 300 periods for 60Hz, Criterion C

16.2.Block Diagram of Test Setup



16.3.Test Procedure

a. Where the equipment has a rated voltage the following shall apply - If the voltage range does not exceed 20% of the lower voltage specified for the rated voltage range, a single voltage within that range may be specified as a basis for test level specification.

- In all other cases, the test procedure shall be applied for both the lowest and highest voltages declared in the voltage range.

b. Test Conditions

- Select operated voltage and frequency of EUT - Test of interval : 10 sec.

- Level and duration : Sequence of 3 dips/interrupts.

- Voltage rise (and fall) time : 1.5 $\mu s.$



16.4.Test results

PASS

Temperature	:	25.4°C
Humidity	:	50%
Atmospheric Pressure	:	101kpa
Test Engineer	:	LHT
Test Date	:	2021-12-15

	Test Level (% UT)	Phase angle (°)	Input Voltage (V)	Freq (Hz)	Duration (periods)	Actual criterion	Required performance criterion	Result (Pass /Fail)
⊠Voltage dips	0%	0°, 180°	AC 230V	50	0.5	А	В	Pass
⊠Voltage dips	0%	0°, 180°	AC 120V	60	0.5	A	В	Pass
⊠Voltage dips	70%	0°, 180°	AC 230V	50	25	A	С	Pass
⊠Voltage dips	70%	0°, 180°	AC 120V	60	30	А	С	Pass
⊠Voltage interruptions	0%	0°, 180°	AC 230V	50	250	В	С	Pass
⊠Voltage interruptions	0%	0°, 180°	AC 120V	60	300	В	С	Pass

Note: 1. Dips to 0%, Duration 250P, EUT stopped operation, but can be automatically restored. 2. Dips to 0%, Duration 300P, EUT stopped operation, but can be automatically restored.



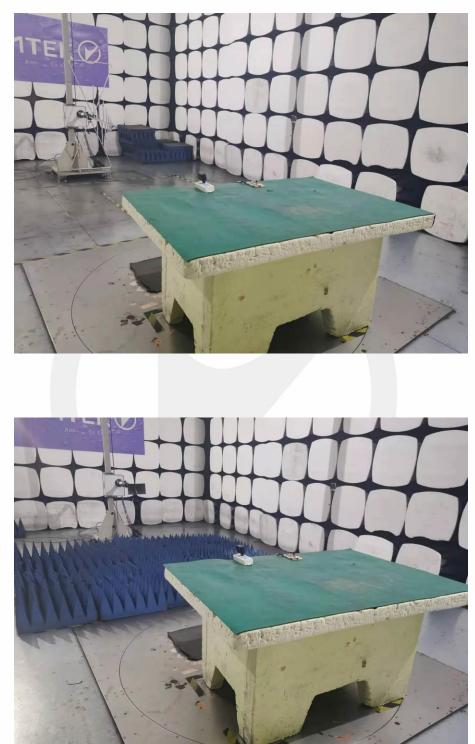
17. PHOTOGRAPHS



17.1.Photos of Conducted Emissions from the AC Mains Power Ports







17.2. Photos of Radiation Emission Measurement





17.3.Photo of Harmonic / Flicker Measurement

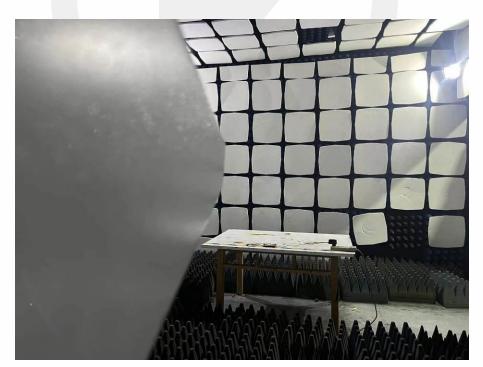
17.4.Photo of Electrostatic Discharges







17.5.Photo of Continuous RF Electromagnetic Field Disturbances





17.6.Photos of Electrical Fast Transients/Burst

AC Mains:



17.7.Photos of Surges

AC Mains:







17.8.Photos of Continuous Induced RF Disturbances

17.9.Photo of Power Frequency Magnetic Field





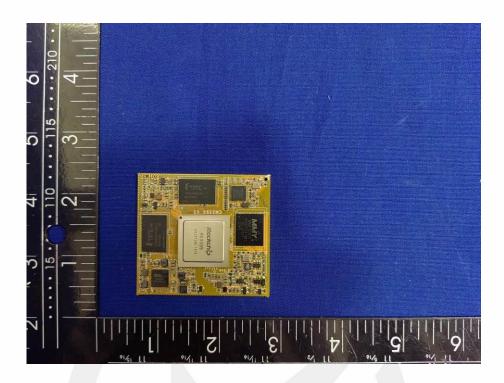


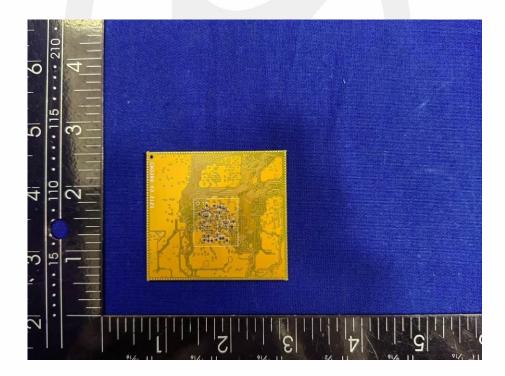
17.10.Photo of Voltage Dips and Interruptions



APPENDIX (PHOTOS OF EUT)







*** End of Report ***